Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/661,852	RAGHUNATH ET AL.	
Examiner	Art Unit	
Ellen C. Tran	2134	

	SEARCHED					
Class	Subclass	Date	Examiner			
726	20	7/18/2007	ET			
726	9	7/18/2007	ET			
713	156	7/18/2007	ET			
713	185	7/18/2007	ET			
713	186	7/18/2007	ET			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
					

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
USPTO, USPG, EPO, JPO, DERWENT, IBM TECH DES	7/18/2007	ET
NPL - IEEE XPLORE	7/18/2007	ET
ALL CLAIMS WERE REVIEWED FOR POSSIBLE 101 REJECTION	7/18/2007	ET
		- (Page 1)